

2N6674, 2N6675, RJH6674, RJH6675

File Number 1164

HARRIS SEMICONDUCTOR

27E D

4302271 0020054 7 HAS

10-A **SwitchMax**  
Power Transistors

High-Voltage N-P-N Types for Off-Line Power Supplies and Other High-Voltage Switching Applications

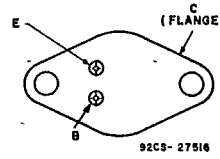
Features:

- Fast switching speed
- High voltage ratings:  
V<sub>CEX</sub>=350 V to 450 V
- Low V<sub>CE(sat)</sub> at I<sub>C</sub>=10 A

Applications:

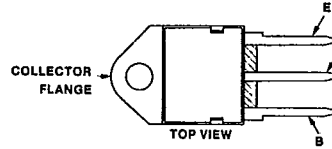
- Off-line power supplies
- High-voltage inverters
- Switching regulators

TERMINAL DESIGNATIONS



JEDEC TO-204AA

2N6674  
2N6675



JEDEC TO-218AC

RJH6674  
RJH6675

The 2N6674, 2N6675, RJH6674, and RJH6675 SwitchMax series of silicon n-p-n power transistors feature high-voltage capability, fast switching speeds, and low saturation voltages, together with high safe-operating-area (SOA) ratings. They are specially designed for off-line power supplies, converter circuits, and pulse-width-modulated regulators. These high-voltage, high-speed transistors are tested for parameters that are essential to the design of high-power switching circuits. Switching times, including inductive turn-off time, and

saturation voltages are specified at 100°C to provide information necessary for worst-case design.

The 2N6674 and 2N6675 transistors are supplied in steel JEDEC TO-204AA hermetic packages. The RJH6674 and RJH6675 transistors are supplied in JEDEC TO-218AC plastic packages.

MAXIMUM RATINGS, Absolute-Maximum Values:

	RJH6674	RJH6675	2N6674	2N6675	
*V <sub>CEV</sub>					
V <sub>BE</sub> =-1.5 V	450	650	450	650	V
*V <sub>CEX</sub> (Clamped)					
V <sub>BE</sub> =-1.5 V	350	450	350	450	V
*V <sub>CEO</sub>	300	400	300	400	V
*V <sub>EB0</sub>					V
I <sub>C</sub> (Sat)					A
*I <sub>C</sub>					A
I <sub>CM</sub>					A
*I <sub>B</sub>					A
*P <sub>T</sub>					W
T <sub>C</sub> up to 25° C					175
T <sub>C</sub> above 25° C, derate linearly	1.4	1.4	1	1	W/°C
*T <sub>sig</sub> , T <sub>J</sub>		-65 to 150		-65 to 200	°C
*T <sub>L</sub>					
At distance ≥ 1/16 in. (1.58 mm) from seating plane for 10 s max				235	°C
TL					
At distance ≥ 1/8" in (3.17 mm) from seating plane for 10 s max		235			°C

\*In accordance with JEDEC registration data (2N6674, 2N6675 only).

2N6674, 2N6675, RJH6674, RJH6675

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ELECTRICAL CHARACTERISTICS

CHARACTERISTIC	TEST CONDITIONS				LIMITS				UNITS
	VOLTAGE V dc		CURRENT A dc		2N6674 RJH6674		2N6675 RJH6675		
	V <sub>CE</sub>	V <sub>BE</sub>	I <sub>C</sub>	I <sub>B</sub>	Min.	Max.	Min.	Max.	

T<sub>C</sub>=25° C

I <sub>CEV</sub>	450 650	-1.5 -1.5			—	0.1	—	—	0.1	mA
I <sub>EB0</sub>		-7	0		—	2	—	2		
V <sub>CE0(sus)</sub> <sup>b</sup>			0.2 <sup>a</sup>	0	300	—	400	—		V
h <sub>FE</sub>	2		10 <sup>a</sup>		8	20	8	20		
V <sub>BE(sat)</sub>			10 <sup>a</sup>	2	—	1.5	—	1.5		V
V <sub>CE(sat)</sub>			10 <sup>a</sup>	2	—	1	—	1		V
			15 <sup>a</sup>	5	—	5	—	5		V
V <sub>CEX</sub> <sup>b</sup> (Clamped E <sub>s</sub> ) L=50 μH, R <sub>EB</sub> =2 Ω		-4	10	2	350	—	450	—		
I <sub>S</sub>	30 100		5.9 0.25		1 1	—	1 1	—		s
h <sub>ie</sub>   f=5 MHz	10		1		3	10	3	10		
f <sub>T</sub>	10		1		15	50	15	50		MHz
C <sub>ob0</sub> f=0.1 MHz	10 <sup>c</sup>				150	500	150	500		pF
t <sub>d</sub> <sup>d</sup>		-6	10	2	—	0.1	—	0.1		μs
t <sub>r</sub> <sup>d</sup>		-6	10	2	—	0.6	—	0.6		
t <sub>s</sub> <sup>d</sup>		-6	10	2 <sup>e</sup>	—	2.5	—	2.5		
t <sub>f</sub> <sup>d</sup>		-6	10	2 <sup>e</sup>	—	0.5	—	0.5		
t <sub>c</sub> V <sub>CC</sub> =135 V, L=50 μH, R <sub>C</sub> ≤ 13.5 Ω, Collector clamped to V <sub>CEX</sub>		-6	10	2 <sup>e</sup>	—	0.5	—	0.5		

T<sub>C</sub>=100° C

I <sub>CEV</sub>	450 650	-1.5 -1.5			—	1	—	—	1	mA
V <sub>CE(sat)</sub>			10 <sup>a</sup>	2	—	2	—	2		V
t <sub>d</sub> <sup>d</sup>		-6	10	2	—	1	—	1		μs
t <sub>r</sub> <sup>d</sup>		-6	10	2 <sup>e</sup>	—	4	—	4		
t <sub>s</sub> <sup>d</sup>		-6	10	2 <sup>e</sup>	—	1	—	1		
t <sub>f</sub> <sup>d</sup>		-6	10	2 <sup>e</sup>	—	1	—	1		
t <sub>c</sub> V <sub>CC</sub> =135 V, L=50 μH, R <sub>C</sub> ≤ 13.5 Ω, Collector clamped to V <sub>CEX</sub>		-6	10	2 <sup>e</sup>	—	0.8	—	0.8		

R <sub>θJC</sub> 2N6674, 2N6675	10		5		—	1	—	1	°C/W
R <sub>θJC</sub> RJH6674, RJH6675	10		5		—	0.71	—	0.71	°C/W

<sup>a</sup>Pulsed: pulse duration=300 μs, duty factor ≤ 2%.

<sup>b</sup>CAUTION: The sustaining voltage V<sub>CE0(sus)</sub> and V<sub>CEX</sub> MUST NOT be measured on a curve tracer.

<sup>c</sup>In accordance with JEDEC registration data (2N6674, 2N6675 only).

<sup>d</sup>V<sub>CE</sub> value.

<sup>e</sup>V<sub>CC</sub>=135 V, t<sub>p</sub>=20 μs.

<sup>f</sup>I<sub>B1</sub> = -I<sub>B2</sub>.



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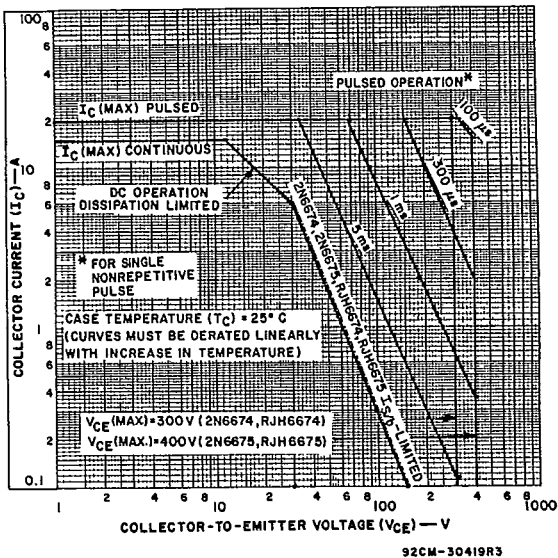


Fig. 1 - Maximum operating areas for all types ( $T_c=25^\circ\text{C}$ ).

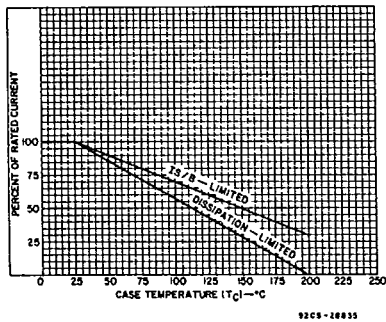


Fig. 2 — Dissipation and  $I_{s,b}$  derating curves for 2N6674 and 2N6675.

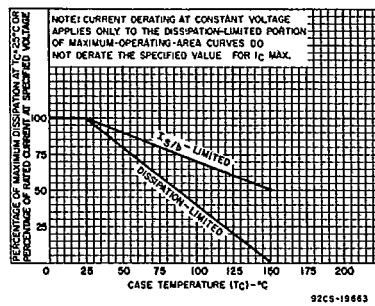


Fig. 3 — Dissipation and  $I_{s,b}$  derating curves for RJH6674 and RJH6675.

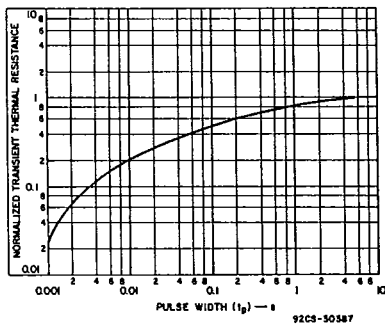


Fig. 4 - Typical thermal-response characteristic for all types.

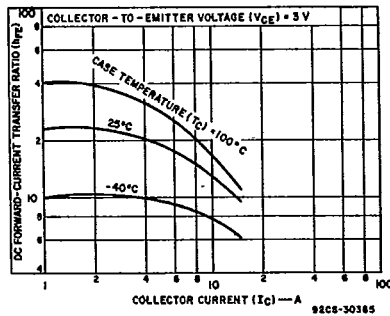


Fig. 5 - Typical dc beta characteristics for all types.

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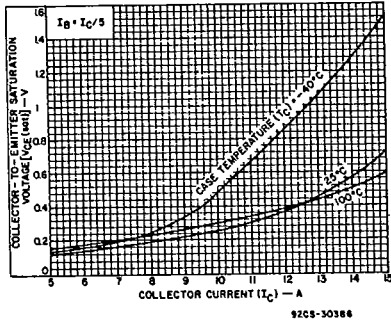


Fig. 6 - Typical collector-to-emitter saturation voltage characteristics for all types.

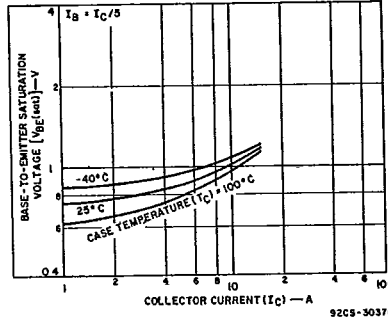


Fig. 7 - Typical base-to-emitter saturation voltage characteristics for all types.

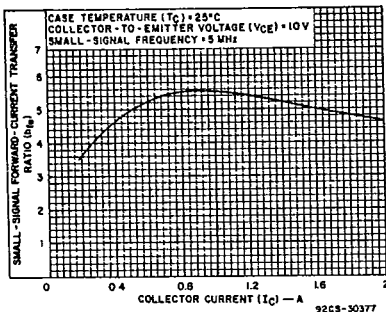


Fig. 8 - Typical small-signal forward current transfer ratio characteristic for all types ( $f=5\text{ MHz}$ ).

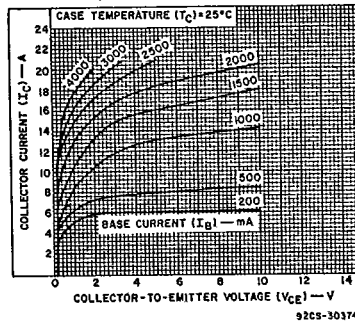


Fig. 9 - Typical output characteristics for all types.

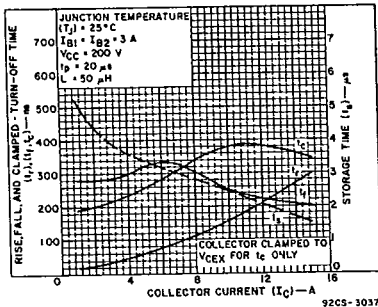


Fig. 10 - Typical saturated-switching-time characteristics at  $T_J=25^\circ\text{C}$  as a function of collector current for all types.

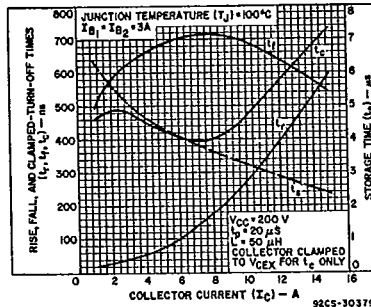


Fig. 11 - Typical saturated-switching-time characteristics at  $T_J=100^\circ\text{C}$  as a function of collector current for all types.

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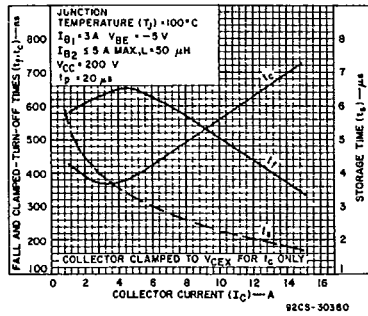


Fig. 12 - Typical saturated-switching-time characteristics at  $T_j=100^\circ\text{C}$  as a function of collector current for all types.

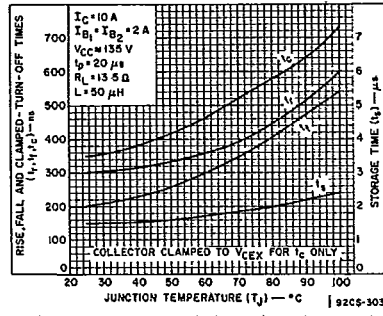


Fig. 13 - Typical saturated-switching-time characteristics as a function of junction temperature for all types.

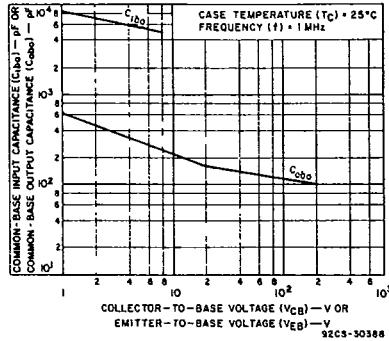


Fig. 14 - Typical common-base input ( $C_{ibo}$ ) or output ( $C_{obo}$ ) capacitance characteristics for all types.

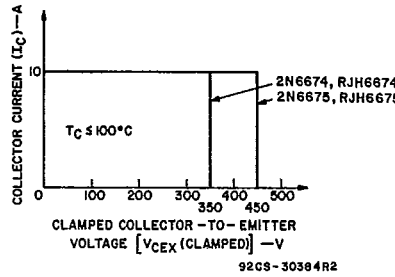


Fig. 15 - Maximum operating conditions for switching between saturation and cutoff for all types.

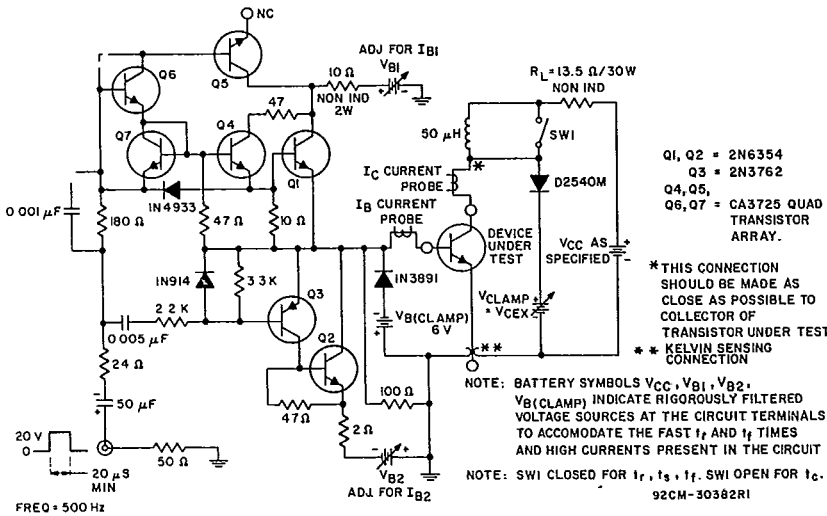


Fig. 16 - Circuit for measuring switching times.

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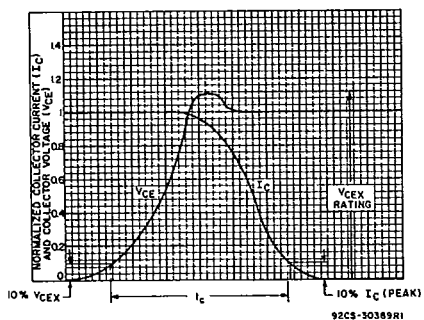
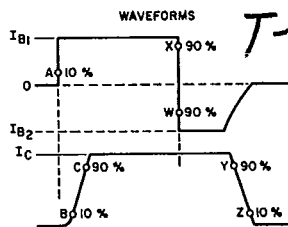


Fig. 17 - Oscilloscope display for normalized measurement of clamped inductive switching time ( $t_c$ ).



$t_d = A-B$      $t_s = X-Y$   
 $t_r = B-C$      $t_f = Y-Z$   
 Transition = X-W  
 NOTE TRANSITION TIME FROM 90%  $I_{B1}$  TO 90%  $I_{B2}$  MUST BE LESS THAN 0.5  $\mu s$ .  
 92CS-30389R1



Fig. 18 - Phase relationship between input and output currents showing reference points for specification of switching times.